

# PH4830L

## N-channel TrenchMOS logic level FET

Rev. 01 — 6 September 2007

Product data sheet

## 1. Product profile

### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

### 1.2 Features

- Logic level threshold
- Optimized for use in DC-to-DC converters
- 100 %  $R_G$  tested
- Lead-free package
- Very low switching and conduction losses
- 100 % ruggedness tested

### 1.3 Applications

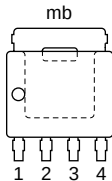
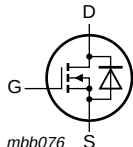
- DC-to-DC converters
- Voltage regulators
- Switched-mode power supplies
- PC Motherboards

### 1.4 Quick reference data

- $V_{DS} \leq 30 \text{ V}$
- $R_{DS(on)} \leq 4.8 \text{ m}\Omega$
- $I_D \leq 84 \text{ A}$
- $Q_{GD} = 5.4 \text{ nC (typ)}$

## 2. Pinning information

Table 1. Pinning

| Pin     | Description                           | Simplified outline                                                                  | Symbol                                                                                |
|---------|---------------------------------------|-------------------------------------------------------------------------------------|---------------------------------------------------------------------------------------|
| 1, 2, 3 | source (S)                            |  |  |
| 4       | gate (G)                              |                                                                                     |                                                                                       |
| mb      | mounting base; connected to drain (D) |                                                                                     |                                                                                       |
|         |                                       | SOT669 (LFPK)                                                                       |                                                                                       |

### 3. Ordering information

**Table 2.** Ordering information

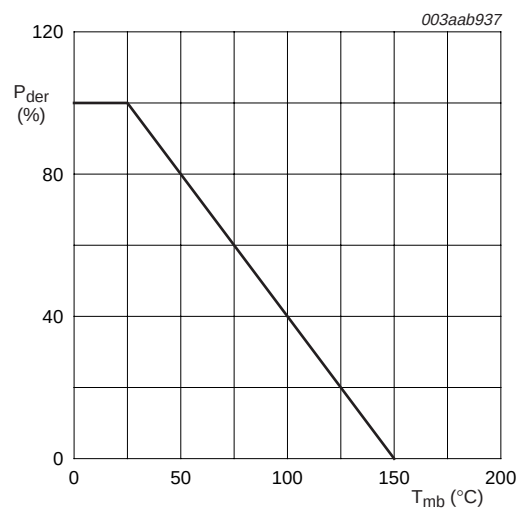
| Type number | Package |                                                               |         |
|-------------|---------|---------------------------------------------------------------|---------|
|             | Name    | Description                                                   | Version |
| PH4830L     | LFPAK   | plastic single-ended surface-mounted package (lfpak); 4 leads | SOT669  |

### 4. Limiting values

**Table 3.** Limiting values

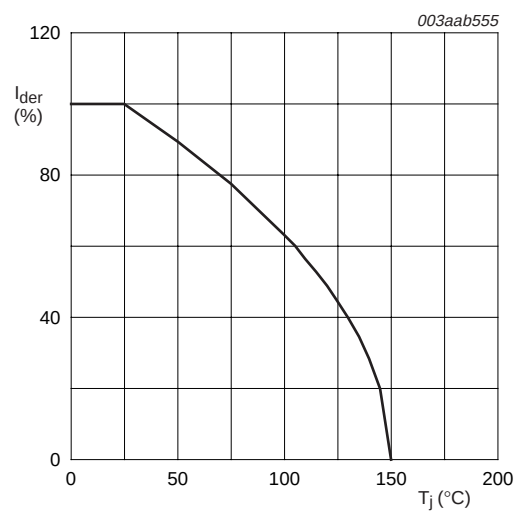
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol                      | Parameter                                    | Conditions                                                                                                                                                                                   | Min | Max      | Unit |
|-----------------------------|----------------------------------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|----------|------|
| $V_{DS}$                    | drain-source voltage                         | $25\text{ °C} \leq T_J \leq 150\text{ °C}$                                                                                                                                                   | -   | 30       | V    |
| $V_{DGR}$                   | drain-gate voltage (DC)                      | $25\text{ °C} \leq T_J \leq 150\text{ °C}$ ; $R_{GS} = 20\text{ k}\Omega$                                                                                                                    | -   | 30       | V    |
| $V_{GS}$                    | gate-source voltage                          |                                                                                                                                                                                              | -   | $\pm 20$ | V    |
| $I_D$                       | drain current                                | $T_{mb} = 25\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 2</a> and <a href="#">3</a>                                                                                        | -   | 84       | A    |
|                             |                                              | $T_{mb} = 100\text{ °C}$ ; $V_{GS} = 10\text{ V}$ ; see <a href="#">Figure 2</a>                                                                                                             | -   | 63       | A    |
| $I_{DM}$                    | peak drain current                           | $T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$ ; see <a href="#">Figure 3</a>                                                                                            | -   | 240      | A    |
| $P_{tot}$                   | total power dissipation                      | $T_{mb} = 25\text{ °C}$ ; see <a href="#">Figure 1</a>                                                                                                                                       | -   | 62.5     | W    |
| $T_{stg}$                   | storage temperature                          |                                                                                                                                                                                              | -55 | +150     | °C   |
| $T_J$                       | junction temperature                         |                                                                                                                                                                                              | -55 | +150     | °C   |
| <b>Source-drain diode</b>   |                                              |                                                                                                                                                                                              |     |          |      |
| $I_S$                       | source current                               | $T_{mb} = 25\text{ °C}$                                                                                                                                                                      | -   | 52       | A    |
| $I_{SM}$                    | peak source current                          | $T_{mb} = 25\text{ °C}$ ; pulsed; $t_p \leq 10\text{ }\mu\text{s}$                                                                                                                           | -   | 208      | A    |
| <b>Avalanche ruggedness</b> |                                              |                                                                                                                                                                                              |     |          |      |
| $E_{DS(AL)S}$               | non-repetitive drain-source avalanche energy | unclamped inductive load; $I_D = 49\text{ A}$ ; $t_p = 0.12\text{ ms}$ ; $V_{DS} \leq 25\text{ V}$ ; $R_{GS} = 50\text{ }\Omega$ ; $V_{GS} = 10\text{ V}$ ; starting at $T_J = 25\text{ °C}$ | -   | 121      | mJ   |



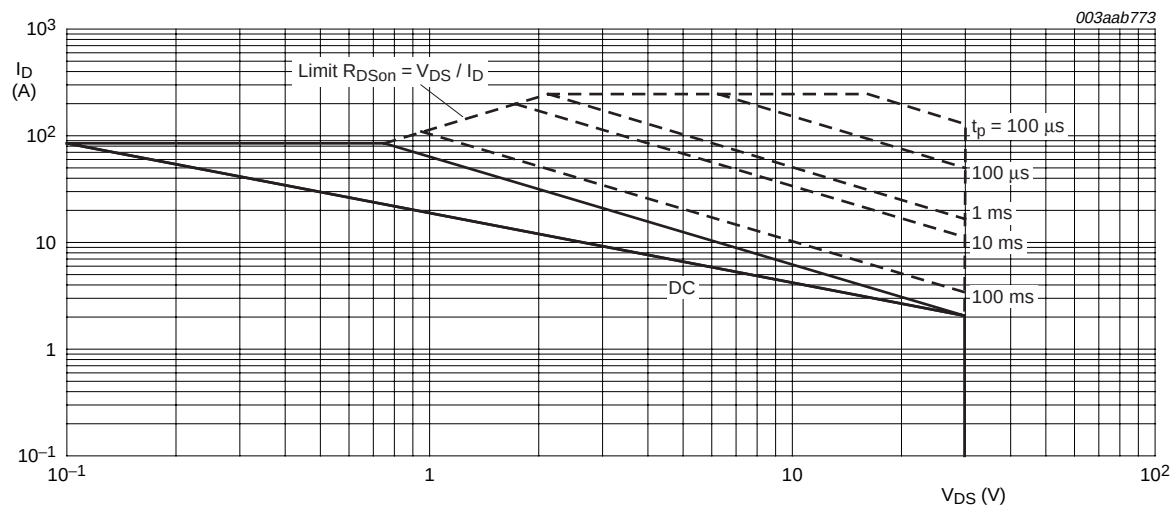
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature



$T_{mb} = 25^{\circ}C$ ;  $I_{DM}$  is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4. Thermal characteristics

| Symbol         | Parameter                                         | Conditions                   | Min | Typ | Max | Unit |
|----------------|---------------------------------------------------|------------------------------|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see <a href="#">Figure 4</a> | -   | -   | 2   | K/W  |

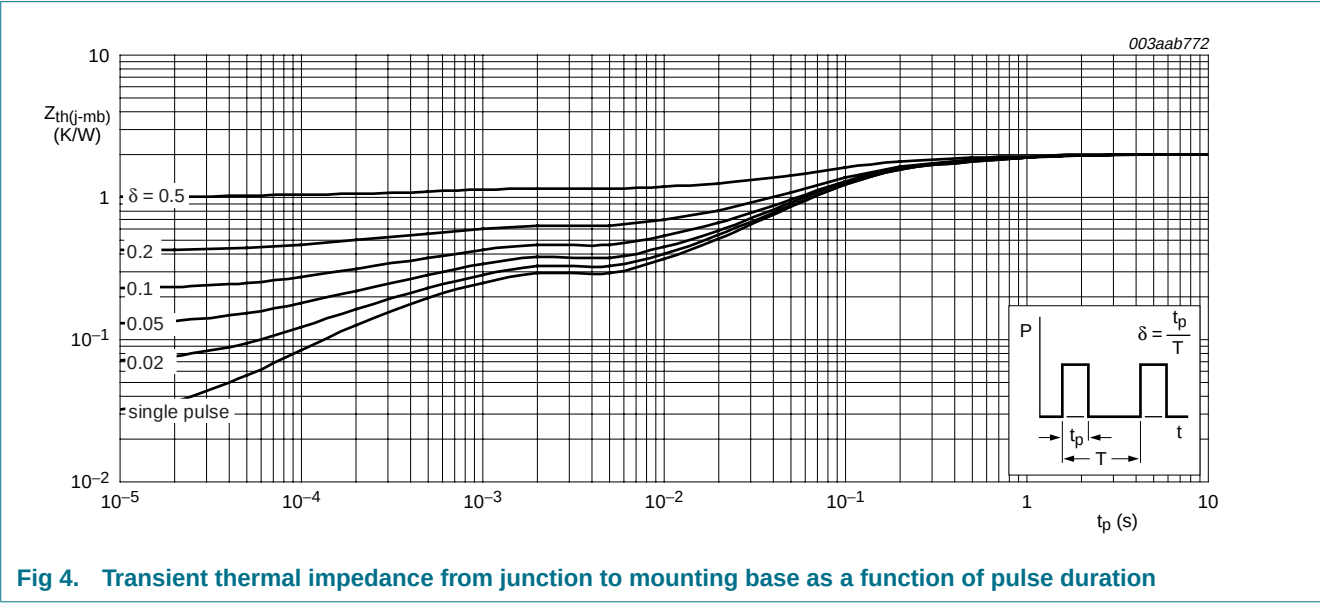


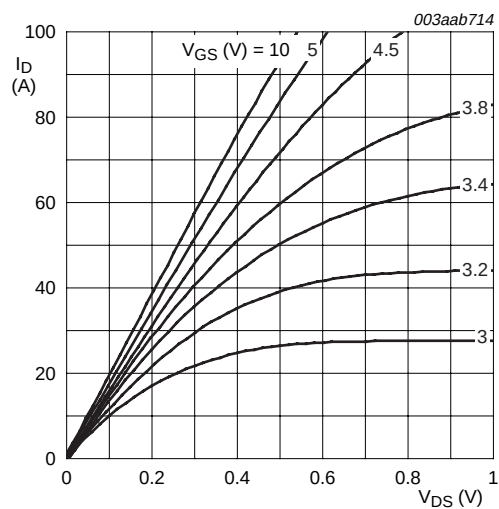
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

## 6. Characteristics

**Table 5. Characteristics**

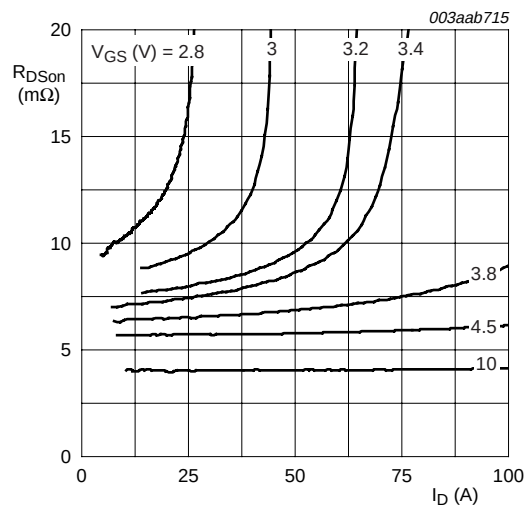
$T_j = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

| Symbol                         | Parameter                             | Conditions                                                                                                                       | Min | Typ  | Max  | Unit          |
|--------------------------------|---------------------------------------|----------------------------------------------------------------------------------------------------------------------------------|-----|------|------|---------------|
| <b>Static characteristics</b>  |                                       |                                                                                                                                  |     |      |      |               |
| $V_{(BR)DSS}$                  | drain-source breakdown voltage        | $I_D = 250\text{ }\mu\text{A}$ ; $V_{GS} = 0\text{ V}$                                                                           |     |      |      |               |
|                                |                                       | $T_j = 25\text{ }^{\circ}\text{C}$                                                                                               | 30  | -    | -    | V             |
|                                |                                       | $T_j = -55\text{ }^{\circ}\text{C}$                                                                                              | 27  | -    | -    | V             |
| $V_{GS(th)}$                   | gate-source threshold voltage         | $I_D = 1\text{ mA}$ ; $V_{DS} = V_{GS}$ ; see <a href="#">Figure 9</a> and <a href="#">10</a>                                    |     |      |      |               |
|                                |                                       | $T_j = 25\text{ }^{\circ}\text{C}$                                                                                               | 1.3 | 1.7  | 2.15 | V             |
|                                |                                       | $T_j = 150\text{ }^{\circ}\text{C}$                                                                                              | 0.8 | -    | -    | V             |
|                                |                                       | $T_j = -55\text{ }^{\circ}\text{C}$                                                                                              | -   | -    | 2.6  | V             |
| $I_{DSS}$                      | drain leakage current                 | $V_{DS} = 30\text{ V}$ ; $V_{GS} = 0\text{ V}$                                                                                   |     |      |      |               |
|                                |                                       | $T_j = 25\text{ }^{\circ}\text{C}$                                                                                               | -   | -    | 1.0  | $\mu\text{A}$ |
|                                |                                       | $T_j = 150\text{ }^{\circ}\text{C}$                                                                                              | -   | -    | 100  | $\mu\text{A}$ |
| $I_{GSS}$                      | gate leakage current                  | $V_{GS} = \pm 20\text{ V}$ ; $V_{DS} = 0\text{ V}$                                                                               | -   | -    | 100  | nA            |
| $R_G$                          | gate resistance                       | $f = 1\text{ MHz}$                                                                                                               | -   | 0.51 | -    | $\Omega$      |
| $R_{DS(on)}$                   | drain-source on-state resistance      | $V_{GS} = 10\text{ V}$ ; $I_D = 25\text{ A}$ ; see <a href="#">Figure 6</a> and <a href="#">8</a>                                |     |      |      |               |
|                                |                                       | $T_j = 25\text{ }^{\circ}\text{C}$                                                                                               | -   | 3.8  | 4.8  | m $\Omega$    |
|                                |                                       | $T_j = 150\text{ }^{\circ}\text{C}$                                                                                              | -   | 6.3  | 7.7  | m $\Omega$    |
|                                |                                       | $V_{GS} = 4.5\text{ V}$ ; $I_D = 25\text{ A}$ ; see <a href="#">Figure 6</a> and <a href="#">8</a>                               | -   | 5.6  | 7.0  | m $\Omega$    |
| <b>Dynamic characteristics</b> |                                       |                                                                                                                                  |     |      |      |               |
| $Q_{G(tot)}$                   | total gate charge                     | $I_D = 25\text{ A}$ ; $V_{DS} = 12\text{ V}$ ; $V_{GS} = 4.5\text{ V}$ ;<br>see <a href="#">Figure 11</a> and <a href="#">12</a> | -   | 22.9 | -    | nC            |
| $Q_{GS}$                       | gate-source charge                    |                                                                                                                                  | -   | 9.0  | -    | nC            |
| $Q_{GS1}$                      | pre- $V_{GS(th)}$ gate-source charge  |                                                                                                                                  | -   | 5.5  | -    | nC            |
| $Q_{GS2}$                      | post- $V_{GS(th)}$ gate-source charge |                                                                                                                                  | -   | 3.5  | -    | nC            |
| $Q_{GD}$                       | gate-drain charge                     |                                                                                                                                  | -   | 5.4  | -    | nC            |
| $V_{GS(pl)}$                   | gate-source plateau voltage           |                                                                                                                                  | -   | 2.8  | -    | V             |
| $C_{iss}$                      | input capacitance                     | $V_{GS} = 0\text{ V}$ ; $V_{DS} = 12\text{ V}$ ; $f = 1\text{ MHz}$ ;<br>see <a href="#">Figure 14</a>                           | -   | 2786 | -    | pF            |
| $C_{oss}$                      | output capacitance                    |                                                                                                                                  | -   | 579  | -    | pF            |
| $C_{rss}$                      | reverse transfer capacitance          |                                                                                                                                  | -   | 297  | -    | pF            |
| $C_{iss}$                      | input capacitance                     | $V_{GS} = 0\text{ V}$ ; $V_{DS} = 0\text{ V}$ ; $f = 1\text{ MHz}$                                                               | -   | 3300 | -    | pF            |
| $t_{d(on)}$                    | turn-on delay time                    | $V_{DS} = 12\text{ V}$ ; $R_L = 0.5\text{ }\Omega$ ; $V_{GS} = 4.5\text{ V}$ ;<br>$R_G = 5.6\text{ }\Omega$                      | -   | 28   | -    | ns            |
| $t_r$                          | rise time                             |                                                                                                                                  | -   | 43   | -    | ns            |
| $t_{d(off)}$                   | turn-off delay time                   |                                                                                                                                  | -   | 35   | -    | ns            |
| $t_f$                          | fall time                             |                                                                                                                                  | -   | 19   | -    | ns            |
| <b>Source-drain diode</b>      |                                       |                                                                                                                                  |     |      |      |               |
| $V_{SD}$                       | source-drain voltage                  | $I_S = 25\text{ A}$ ; $V_{GS} = 0\text{ V}$ ; see <a href="#">Figure 13</a>                                                      | -   | 0.85 | -    | V             |
| $t_{rr}$                       | reverse recovery time                 | $I_S = 20\text{ A}$ ; $dI_S/dt = -100\text{ A}/\mu\text{s}$ ; $V_{GS} = 0\text{ V}$ ;<br>$V_R = 30\text{ V}$                     | -   | 47   | -    | ns            |
| $Q_r$                          | recovered charge                      |                                                                                                                                  | -   | 17   | -    | nC            |



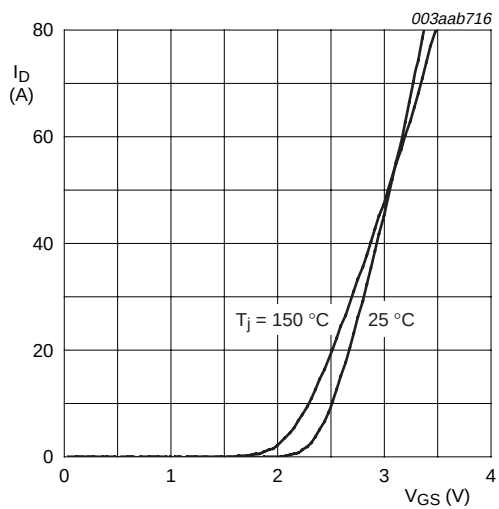
$T_j = 25\text{ }^{\circ}\text{C}$

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



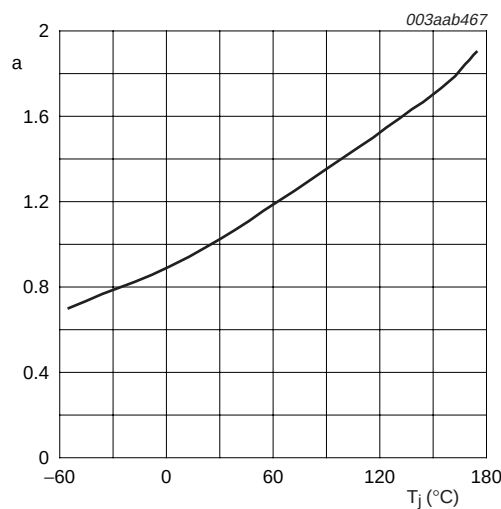
$T_j = 25\text{ }^{\circ}\text{C}$

Fig 6. Drain-source on-state resistance as a function of drain current; typical values



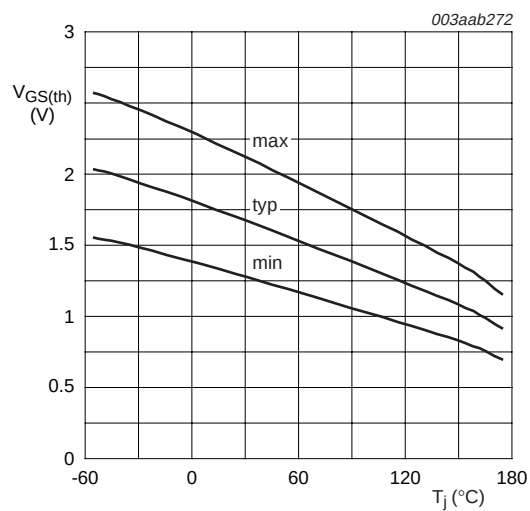
$T_j = 25\text{ }^{\circ}\text{C}$  and  $150\text{ }^{\circ}\text{C}$ ;  $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



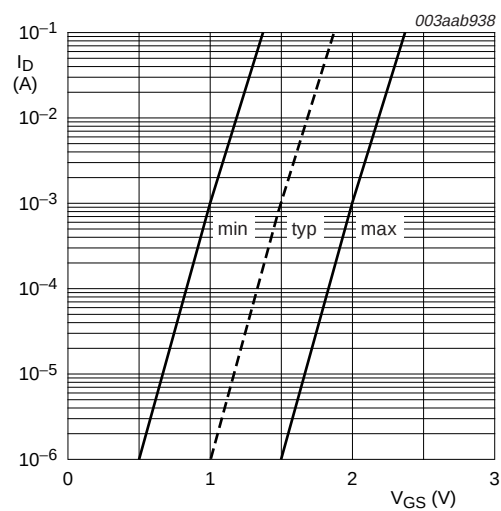
$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}\text{C})}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



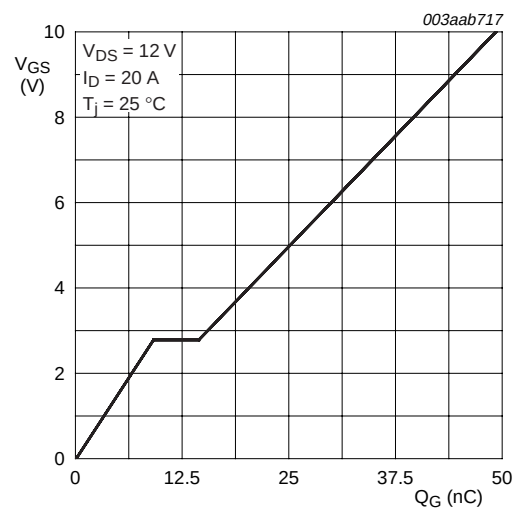
$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

Fig 9. Gate-source threshold voltage as a function of junction temperature



$T_j = 25\text{ °C}; V_{DS} = 5\text{ V}$

Fig 10. Sub-threshold drain current as a function of gate-source voltage



$I_D = 20\text{ A}; V_{DS} = 12\text{ V}$

Fig 11. Gate-source voltage as a function of gate charge; typical values

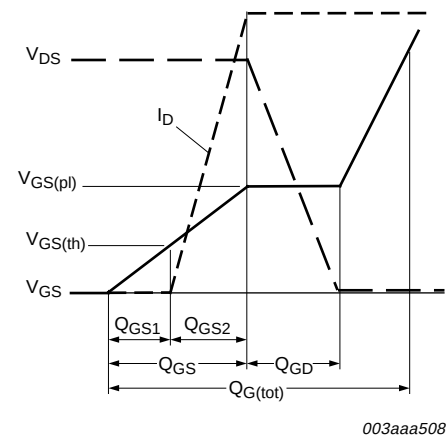
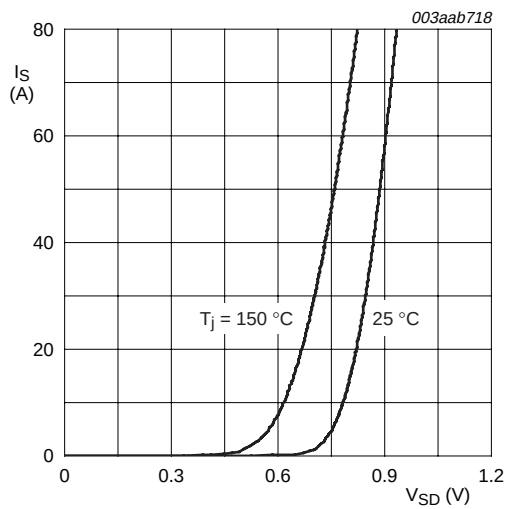
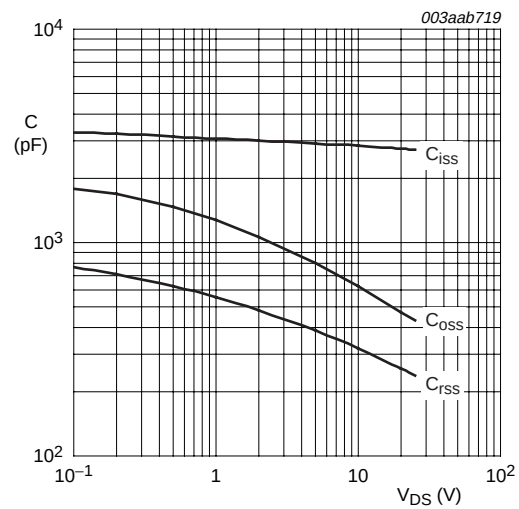


Fig 12. Gate charge waveform definitions



$T_j = 25\text{ }^{\circ}\text{C}$  and  $150\text{ }^{\circ}\text{C}$ ;  $V_{GS} = 0\text{ V}$

Fig 13. Source current as a function of source-drain voltage; typical values



$V_{GS} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



7. Package outline

Plastic single-ended surface-mounted package (LPAK); 4 leads SOT669

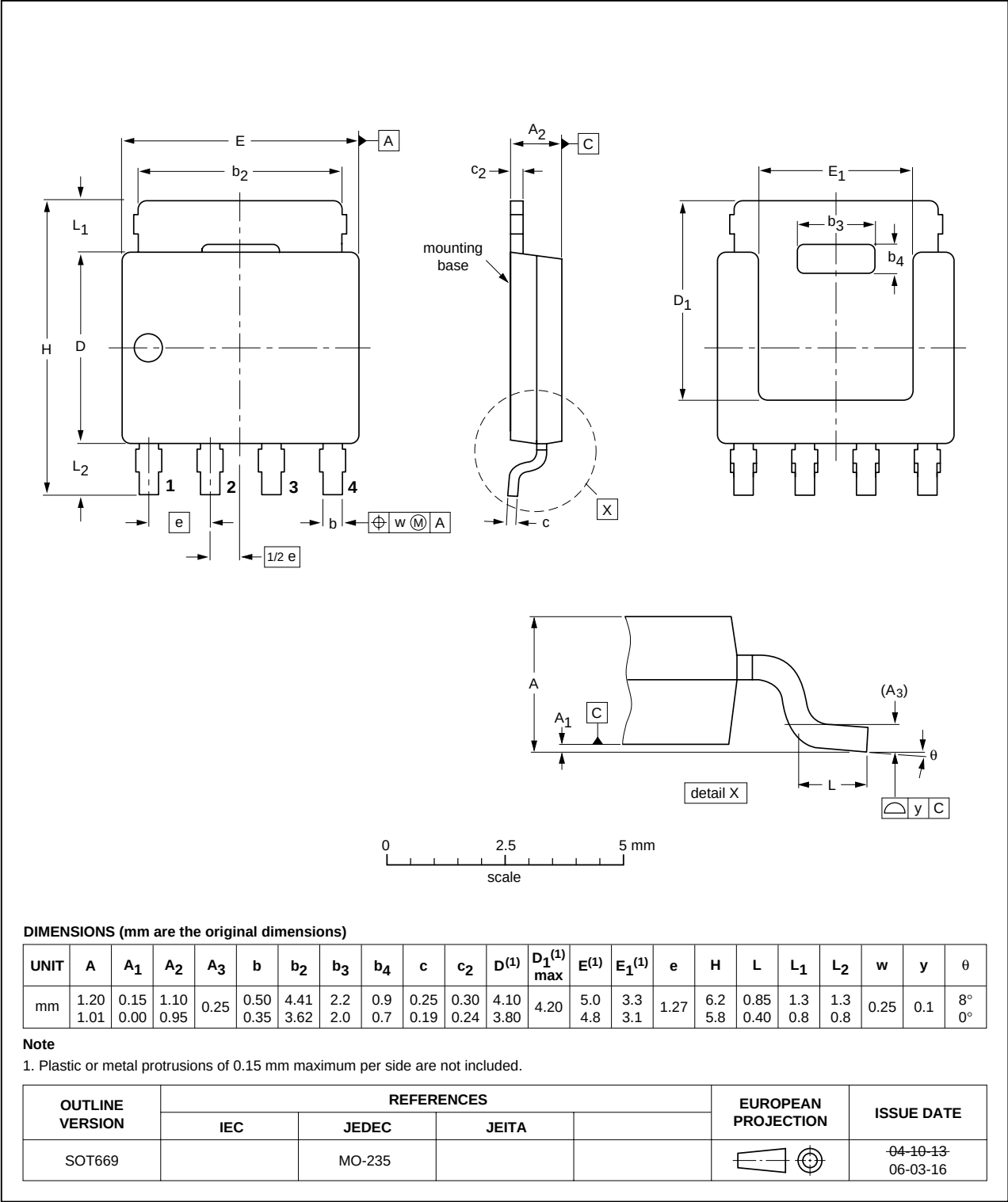


Fig 15. Package outline SOT669 (LPAK)

## 8. Revision history

Table 6. Revision history

| Document ID | Release date | Data sheet status  | Change notice | Supersedes |
|-------------|--------------|--------------------|---------------|------------|
| PH4830L_1   | 20070906     | Product data sheet | -             | -          |

## 9. Legal information

### 9.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition                                                                            |
|-----------------------------------|-------------------------------|---------------------------------------------------------------------------------------|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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